Hydrogen Peroxide, 30% CMOS (Stabilized)





Material No.: 2190-23 Batch No.: 0000120497 Manufactured Date: 2015/08/26 Expiration Date: 2017/02/23

## Certificate of Analysis

Test	Specification	Result
Assay (H2O2)	30.0 - 32.0 %	31.6
Color (APHA)	<= 10	5
ree Acid (μeq/g)	<= 0.2	< 0.2
Residue after Evaporation	<= 10 ppm	2
Ammonium (NH4)	<= 3 ppm	< 3
Chloride (Cl)	<= 0.2 ppm	< 0.2
Nitrate (NO3)	<= 2 ppm	< 2
Phosphate (PO4)	<= l ppm	< 1
Sulfate (SO4)	<= 3 ppm	< 3
Frace Impurities – Aluminum (Al)	<= 70.0 ppb	12.7
Arsenic and Antimony (as As)	<= 10 ppb	< 10
Frace Impurities – Barium (Ba)	<= 20.0 ppb	< 1.0
Frace Impurities – Beryllium (Be)	<= 10.0 ppb	< 1.0
Frace Impurities – Bismuth (Bi)	<= 20.0 ppb	< 10.0
Frace Impurities – Boron (B)	<= 10.0 ppb	< 5.0
Frace Impurities – Cadmium (Cd)	<= 10.0 ppb	< 1.0
Frace Impurities – Calcium (Ca)	<= 50.0 ppb	< 1.0
Frace Impurities – Chromium (Cr)	<= 20.0 ppb	2.2
Frace Impurities – Cobalt (Co)	<= 10.0 ppb	< 1.0
Frace Impurities – Copper (Cu)	<= 10.0 ppb	< 1.0
Frace Impurities – Gallium (Ga)	<= 20.0 ppb	< 1.0
Frace Impurities – Germanium (Ge)	<= 10.0 ppb	< 10.0
Frace Impurities – Gold (Au)	<= 10.0 ppb	< 5.0
Heavy Metals (as Pb)	<= 500 ppb	< 250

For questions on this Certificate of Analysis please contact Technical Services at 855.282.6867 or +1.610.573.2600 Avantor ™ Performance Materials Inc.

3477 Corporate Parkway. Suite #200. Center Valley, PA 18034. U.S.A. Phone: 610.573.2600 . Fax: 610.573.2610

Test	Specification	Result
Trace Impurities – Iron (Fe)	<= 50.0 ppb	3.4
Trace Impurities – Lead (Pb)	<= 10.0 ppb	< 10.0
Trace Impurities – Lithium (Li)	<= 10.0 ppb	< 1.0
Trace Impurities – Magnesium (Mg)	<= 10.0 ppb	< 1.0
Trace Impurities – Manganese (Mn)	<= 10.0 ppb	< 1.0
Trace Impurities – Molybdenum (Mo)	<= 10.0 ppb	< 5.0
Trace Impurities – Nickel (Ni)	<= 10.0 ppb	< 5.0
Trace Impurities – Niobium (Nb)	<= 10.0 ppb	< 1.0
Trace Impurities – Potassium (K)	<= 600.0 ppb	151.4
Trace Impurities – Silicon (Si)	<= 100.0 ppb	< 10.0
Trace Impurities – Silver (Ag)	<= 10.0 ppb	< 1.0
Trace Impurities – Sodium (Na)	<= 100.0 ppb	< 5.0
Trace Impurities – Strontium (Sr)	<= 10.0 ppb	< 1.0
Trace Impurities – Tantalum (Ta)	<= 10.0 ppb	< 5.0
Trace Impurities – Thallium (TI)	<= 50.0 ppb	< 5.0
Trace Impurities – Tin (Sn)	190.0 – 500.0 ppb	247.7
Trace Impurities – Titanium (Ti)	<= 10.0 ppb	< 1.0
Trace Impurities – Vanadium (V)	<= 10.0 ppb	< 1.0
Trace Impurities – Zinc (Zn)	<= 50.0 ppb	< 1.0
Trace Impurities – Zirconium (Zr)	<= 10.0 ppb	< 1.0
Particle Count – 0.5 µm and greater	<= 100 par/ml	56
Particle Count – 1.0 µm and greater	<= 10 par/ml	6

For Microelectronic Use

Country of Origin: US Packaging Site: Paris Mfg Ctr & DC



Phillipsburg, NJ 9001:2008, 14001:2004, FSSC 22000 Paris, KY 9001:2008 Mexico City, Mexico 9001:2008 Deventer, The Netherlands 9001:2008, 14001:2004, 13485:2003 Gliwice, Poland 9001:2008 Selangor, Malaysia 9001:2008 Dehradun, India, 9001:2008, 14001:2004, 13485:2003 Mumbai, India, 9001:2008, 17025:2005 Panoli, India 9001:2008

James Techie

Jamie Ethier Vice President Global Quality

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